SCCS019D - MAY 1994 - REVISED NOVEMBER 2001

- Function, Pinout, and Drive Compatible With FCT and F Logic
- Reduced V_{OH} (Typically = 3.3 V) Version of Equivalent FCT Functions
- Edge-Rate Control Circuitry for Significantly Improved Noise Characteristics
- I_{off} Supports Partial-Power-Down Mode Operation
- Matched Rise and Fall Times
- Fully Compatible With TTL Input and Output Logic Levels
- ESD Protection Exceeds JESD 22
 - 2000-V Human-Body Model (A114-A)
 - 200-V Machine Model (A115-A)
 - 1000-V Charged-Device Model (C101)
- 64-mA Output Sink Current
 32-mA Output Source Current
- 3-State Outputs

Q OR SO PACKAGE (TOP VIEW) S 16 NCC 15 OE I_{0a} 14 | I_{0c} I_{1a} [] 3 Y_a [] 4 13 I_{1c} I_{0b} [] 5 12 Y_C 11 🛮 I_{0d} 6 I_{1b} 10 | I_{1d} Y_b [] 7 GND 8 9]] Y^d

description

The CY74FCT257T has four identical two-input multiplexers that select four bits of data from two sources under the control of a common data-select (S) input. The I_0 inputs are selected when S is low, and the I_1 inputs are selected when S is high. Data at the output is noninverted.

The CY74FCT257T is a logic implementation of a four-pole, two-position switch, where the position of the switch is determined by the logic levels at S. Outputs are in the high-impedance state when the output-enable (\overline{OE}) input is high.

All but one device must be in the high-impedance state to avoid currents exceeding the maximum ratings if outputs are tied together. $\overline{\text{OE}}$ inputs must ensure that there is no overlap when outputs of 3-state devices are tied together.

This device is fully specified for partial-power-down applications using I_{off}. The I_{off} circuitry disables the outputs, preventing damaging current backflow through the device when it is powered down.

PIN DESCRIPTION

NAME	DESCRIPTION
I	Data inputs
S	Common data-select input
ŌĒ	Output-enable input (active low)
Υ	Data outputs



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.



ORDERING INFORMATION

T _A	PACI	KAGE†	SPEED (ns)	ORDERABLE PART NUMBER	TOP-SIDE MARKING
	QSOP – Q	Tape and reel	4.3	CY74FCT257CTQCT	FT257-3
	SOIC - SO	Tube	4.3	CY74FCT257CTSOC	F0T0F70
-40°C to 85°C		Tape and reel	4.3	CY74FCT257CTSOCT	FCT257C
	QSOP – Q	Tape and reel	5	CY74FCT257ATQCT	FT257-1
	QSOP - Q	Tape and reel	6	CY74FCT257TQCT	FT257

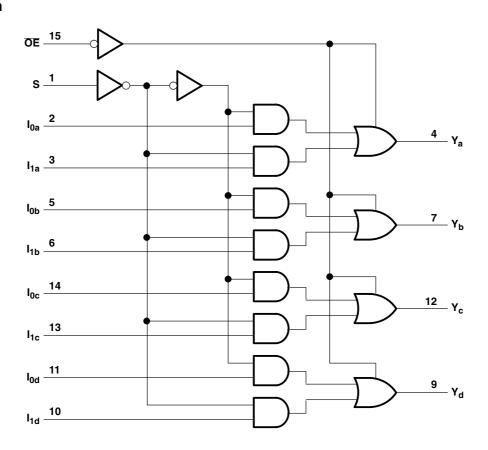
 $^{^{\}dagger} \ \text{Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines}$ are available at www.ti.com/sc/package.

FUNCTION TABLE

	INP	OUTPUT		
OE	S	I ₀	I ₁	Υ
Н	Χ	Χ	Х	Z
L	Н	Χ	L	L
L	Н	Χ	Н	Н
L	L	L	Χ	L
L	L	Н	Χ	Н

H = High logic level, L = Low logic level, X = Don't care, Z = High-impedance state

logic diagram





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absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Supply voltage range to ground potential	–0.5 V to 7 V
DC input voltage range	–0.5 V to 7 V
DC output voltage range	–0.5 V to 7 V
DC output current (maximum sink current/pin)	120 mA
Package thermal impedance, θ _{JA} (see Note 1): Q package	90°C/W
SO package	57°C/W
Ambient temperature range with power applied, T _A	–65°C to 135°C
Storage temperature range, T _{stq}	65°C to 150°C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTE 1: The package thermal impedance is calculated in accordance with JESD 51-7.

recommended operating conditions (see Note 2)

		MIN	NOM	MAX	UNIT
V _{CC}	Supply voltage	4.75	5	5.25	V
V _{IH}	High-level input voltage	2			V
V_{IL}	Low-level input voltage			8.0	V
I _{OH}	High-level output current			-32	mA
I _{OL}	Low-level output current			64	mA
T _A	Operating free-air temperature	-40		85	°C

NOTE 2: All unused inputs of the device must be held at V_{CC} or GND to ensure proper device operation.



CY74FCT257T QUAD 2-INPUT MULTIPLEXER WITH 3-STATE OUTPUTS

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electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS		MIN	TYP†	MAX	UNIT
V _{IK}	$V_{CC} = 4.75,$	I _{IN} = -18 mA			-0.7	-1.2	V
V _{OH}	$V_{CC} = 4.75,$	2			٧		
V _{OL}	$V_{CC} = 4.75,$	$I_{OL} = 64 \text{ mA}$			0.3	0.55	V
V _{hys}	All inputs				0.2		٧
I _I	$V_{CC} = 5.25 \text{ V},$	V _{IN} = 5.25 V				5	μΑ
I _{IH}	$V_{CC} = 5.25 \text{ V},$	$V_{IN} = 2.7 \text{ V}$				±1	μΑ
I _{IL}	$V_{CC} = 5.25 \text{ V},$	$V_{IN} = 0.5 V$				±1	μΑ
I _{OZH}	$V_{CC} = 5.25 \text{ V},$	V _{OUT} = 2.7 V				10	μΑ
I _{OZL}	$V_{CC} = 5.25 \text{ V},$	V _{OUT} = 0.5 V				-10	μΑ
los [‡]	$V_{CC} = 5.25 \text{ V},$	V _{OUT} = 0 V		-60	-120	-225	mA
I _{off}	$V_{CC} = 0 V$,	V _{OUT} = 4.5 V				±1	μΑ
I _{CC}	$V_{CC} = 5.25 \text{ V},$	$V_{IN} \le 0.2 V$	$V_{IN} \ge V_{CC} - 0.2 V$		0.1	0.2	mA
ΔI_{CC}	$V_{CC} = 5.25 \text{ V}, V_{IN} = 3$.4 V§, f ₁ = 0, Outputs open			0.5	2	mA
I _{CCD} ¶		out switching at 50% duty of $V_{IN} \ge V_{CC} - 0.2 V$	cycle, Outputs open,		0.06	0.12	mA/ MHz
		One input switching at f ₁ = 10 MHz	$\begin{aligned} &V_{IN} \leq 0.2 \text{ V or} \\ &V_{IN} \geq V_{CC} - 0.2 \text{ V} \end{aligned}$		0.7	1.4	
. #	$V_{CC} = 5.25 \text{ V},$ Outputs open,	at 50% duty cycle	$V_{IN} = 3.4 \text{ V or GND}$		1	2.4	A
I _C #	OE = GND	Four bits switching at f ₁ = 2.5 MHz	$V_{IN} \le 0.2 \text{ V or}$ $V_{IN} \ge V_{CC} - 0.2 \text{ V}$	0.7		1.4	mA
		at 50% duty cycle	V _{IN} = 3.4 V or GND		1.7	5.4	
C _i					5	10	pF
Co					9	12	pF

[†] Typical values are at $V_{CC} = 5 \text{ V}$, $T_A = 25^{\circ}\text{C}$.

Where:

I_C = Total supply current

I_{CC} = Power-supply current with CMOS input levels

 ΔI_{CC} = Power-supply current for a TTL high input (V_{IN} = 3.4 V)

 D_H = Duty cycle for TTL inputs high N_T = Number of TTL inputs at D_H

I_{CCD} = Dynamic current caused by an input transition pair (HLH or LHL)

f₀ = Clock frequency for registered devices, otherwise zero

f₁ = Input signal frequency

N₁ = Number of inputs changing at f₁

All currents are in milliamperes and all frequencies are in megahertz.

| Values for these conditions are examples of the I_{CC} formula.



^{*} Not more than one output should be shorted at a time. Duration of short should not exceed one second. The use of high-speed test apparatus and/or sample-and-hold techniques are preferable to minimize internal chip heating and more accurately reflect operational values. Otherwise, prolonged shorting of a high output can raise the chip temperature well above normal and cause invalid readings in other parametric tests. In any sequence of parameter tests, I_{OS} tests should be performed last.

[§] Per TTL-driven input (V_{IN} = 3.4 V); all other inputs at V_{CC} or GND

[¶] This parameter is derived for use in total power-supply calculations.

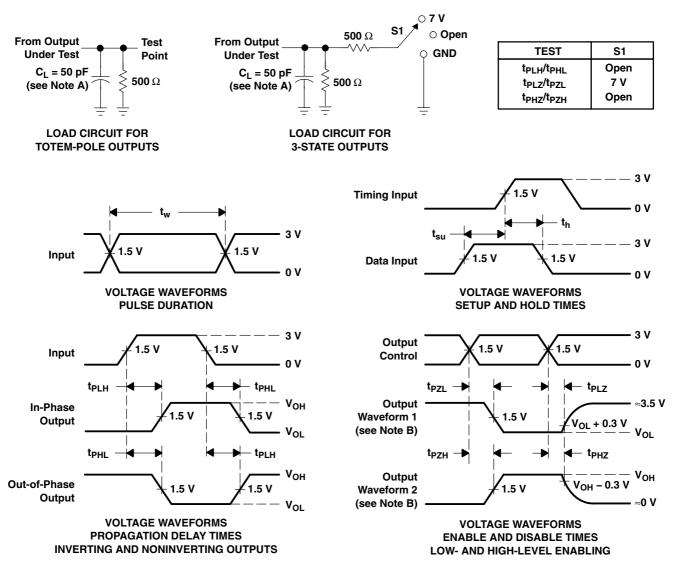
[#] I_C = $I_{CC} + \Delta I_{CC} \times D_H \times N_T + I_{CCD}(f_0/2 + f_1 \times N_1)$

CY74FCT257T **QUAD 2-INPUT MULTIPLEXER** WITH 3-STATE OUTPUTS SCCS019D - MAY 1994 - REVISED NOVEMBER 2001

switching characteristics over operating free-air temperature range (see Figure 1)

DADAMETED	FROM	то	CY74F0	FCT257T CY74FCT257AT CY74FCT257CT			Г257СТ			
PARAMETER	(INPUT)	(OUTPUT)	MIN	MAX	MIN	MAX	MIN	MAX	UNIT	
t _{PLH}		V	1.5	6	1.5	5	1.5	4.3		
t _{PHL}	I	Y	1.5	6	1.5	5	1.5	4.3	ns	
t _{PLH}		V	1.5	10.5	1.5	7	1.5	5.2		
t _{PHL}	S	Y	1.5	10.5	1.5	7	1.5	5.2	ns	
t _{PZH}	Δ .	V	1.5	8.5	1.5	7	1.5	6		
t _{PZL}	ŌĒ	Y	1.5	8.5	1.5	7	1.5	6	ns	
t _{PHZ}	OF.		V	1.5	6	1.5	5.5	1.5	5	
t _{PLZ}		ŌE Y	1.5	6	1.5	5.5	1.5	5	ns	

PARAMETER MEASUREMENT INFORMATION



NOTES: A. C₁ includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. The outputs are measured one at a time with one input transition per measurement.

Figure 1. Load Circuit and Voltage Waveforms



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PACKAGING INFORMATION

Orderable part number	Status	Material type	Package Pins	Package qty Carrier	RoHS	Lead finish/ Ball material	MSL rating/ Peak reflow	Op temp (°C)	Part marking
	(1)	(2)			(3)	(4)	(5)		(0)
CY74FCT257ATD	Active	Production	SOIC (D) 16	40 TUBE	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	FCT257AT
CY74FCT257ATD.B	Active	Production	SOIC (D) 16	40 TUBE	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	FCT257AT
CY74FCT257ATQCT	Active	Production	SSOP (DBQ) 16	2500 LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 85	FT257-1
CY74FCT257ATQCT.B	Active	Production	SSOP (DBQ) 16	2500 LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 85	FT257-1
CY74FCT257CTSOC	Active	Production	SOIC (DW) 16	40 TUBE	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	FCT257C
CY74FCT257CTSOC.B	Active	Production	SOIC (DW) 16	40 TUBE	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	FCT257C
CY74FCT257TQCT	Active	Production	SSOP (DBQ) 16	2500 LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 85	FT257
CY74FCT257TQCT.B	Active	Production	SSOP (DBQ) 16	2500 LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 85	FT257

⁽¹⁾ Status: For more details on status, see our product life cycle.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

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⁽²⁾ Material type: When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

⁽³⁾ RoHS values: Yes, No, RoHS Exempt. See the TI RoHS Statement for additional information and value definition.

⁽⁴⁾ Lead finish/Ball material: Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

⁽⁵⁾ MSL rating/Peak reflow: The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

⁽⁶⁾ Part marking: There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

PACKAGE OPTION ADDENDUM

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In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

PACKAGE MATERIALS INFORMATION

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TAPE AND REEL INFORMATION





A0	Dimension designed to accommodate the component width
В0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal

Device		Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
CY74FCT257ATQCT	SSOP	DBQ	16	2500	330.0	12.5	6.4	5.2	2.1	8.0	12.0	Q1
CY74FCT257TQCT	SSOP	DBQ	16	2500	330.0	12.5	6.4	5.2	2.1	8.0	12.0	Q1

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*All dimensions are nominal

Device	Package Type	Package Type Package Drawing Pins		SPQ	Length (mm)	Width (mm)	Height (mm)
CY74FCT257ATQCT	SSOP	DBQ	16	2500	340.5	338.1	20.6
CY74FCT257TQCT	SSOP	DBQ	16	2500	340.5	338.1	20.6

PACKAGE MATERIALS INFORMATION

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TUBE



*All dimensions are nominal

Device	Package Name	Package Type	Pins	SPQ	L (mm)	W (mm)	T (µm)	B (mm)
CY74FCT257ATD	D	SOIC	16	40	507	8	3940	4.32
CY74FCT257ATD.B	D	SOIC	16	40	507	8	3940	4.32
CY74FCT257CTSOC	DW	SOIC	16	40	506.98	12.7	4826	6.6
CY74FCT257CTSOC.B	DW	SOIC	16	40	506.98	12.7	4826	6.6

D (R-PDS0-G16)

PLASTIC SMALL OUTLINE



NOTES:

- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.006 (0,15) each side.
- Body width does not include interlead flash. Interlead flash shall not exceed 0.017 (0,43) each side.
- E. Reference JEDEC MS-012 variation AC.



7.5 x 10.3, 1.27 mm pitch

SMALL OUTLINE INTEGRATED CIRCUIT

This image is a representation of the package family, actual package may vary. Refer to the product data sheet for package details.





SOIC



NOTES:

- 1. All linear dimensions are in millimeters. Dimensions in parenthesis are for reference only. Dimensioning and tolerancing
- per ASME Y14.5M.

 2. This drawing is subject to change without notice.

 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15 mm, per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm, per side.
- 5. Reference JEDEC registration MS-013.



SOIC



NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



SOIC



NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.





SHRINK SMALL-OUTLINE PACKAGE



NOTES:

- 1. Linear dimensions are in inches [millimeters]. Dimensions in parenthesis are for reference only. Controlling dimensions are in inches. Dimensioning and tolerancing per ASME Y14.5M.
- 2. This drawing is subject to change without notice.
- 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed .006 inch, per side.
- 4. This dimension does not include interlead flash.5. Reference JEDEC registration MO-137, variation AB.



SHRINK SMALL-OUTLINE PACKAGE



NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



SHRINK SMALL-OUTLINE PACKAGE



NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.



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